74AUP1Z04

Low-power X-tal driver with enable and internal resistor

Rev. 01 — 12 December 2006

Product data sheet

1. General description

The 74AUP1Z04 is a high-performance, low-power, low-voltage, Si-gate CMOS device, superior to most advanced CMOS compatible TTL families.

The 74AUP1Z04 combines the functions of the 74AUP1GU04 and 74AUP1G04 with enable circuitry and an internal bias resistor to provide a device optimized for use in crystal oscillator applications.

This device ensures a very low static and dynamic power consumption across the entire V_{CC} range from 0.8 V to 3.6 V.

This device is fully specified for partial power-down applications using I_{OFF} at output Y. The I_{OFF} circuitry disables the output Y, preventing the damaging backflow current through the device when it is powered down.

When not in use the \overline{EN} input can be driven HIGH, pulling up the X1 input and putting the device in a low power disable mode. Schmitt-trigger action at the \overline{EN} input makes the circuit tolerant to slower input rise and fall times across the entire V_{CC} range from 0.8 V to 3.6 V.

The integration of the two devices into the 74AUP1Z04 produces the benefits of a compact footprint, lower power dissipation and stable operation over a wide range of frequency and temperature.

2. Features

- Wide supply voltage range from 0.8 V to 3.6 V
- High noise immunity
- ESD protection:
 - ◆ HBM JESD22-A114D Class 3A exceeds 5000 V
 - MM JESD22-A115-A exceeds 200 V
 - ◆ CDM JESD22-C101C exceeds 1000 V
- Low static power consumption; $I_{CC} = 0.9 \,\mu\text{A}$ (maximum)
- Latch-up performance exceeds 100 mA per JESD 78 Class II
- Inputs accept voltages up to 3.6 V
- Low noise overshoot and undershoot < 10 % of V_{CC}
- I_{OFF} circuitry provides partial Power-down mode operation at output Y
- Multiple package options
- Specified from -40 °C to +85 °C and -40 °C to +125 °C



Low-power X-tal driver with enable and internal resistor

3. Ordering information

Table 1. Ordering information

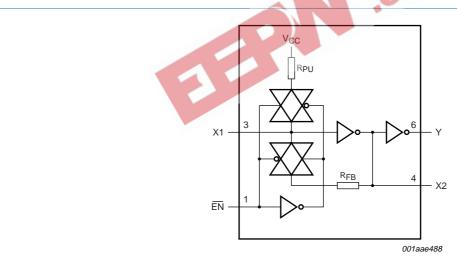
Type number	Package						
	Temperature range	Name	Description	Version			
74AUP1Z04GW	–40 °C to +125 °C	SC-88	plastic surface-mounted package; 6 leads	SOT363			
74AUP1Z04GM	–40 °C to +125 °C	XSON6	plastic extremely thin small outline package; no leads; 6 terminals; body 1 \times 1.45 \times 0.5 mm	SOT886			
74AUP1Z04GF	–40 °C to +125 °C	XSON6	plastic extremely thin small outline package; no leads; 6 terminals; body 1 \times 1 \times 0.5 mm	SOT891			

4. Marking

Table 2. Marking

Type number	Marking code
74AUP1Z04GW	a4
74AUP1Z04GM	a4
74AUP1Z04GF	a4 a

5. Functional diagram



 R_{PU} = pull-up resistance.

R_{FB} = feed-back resistance.

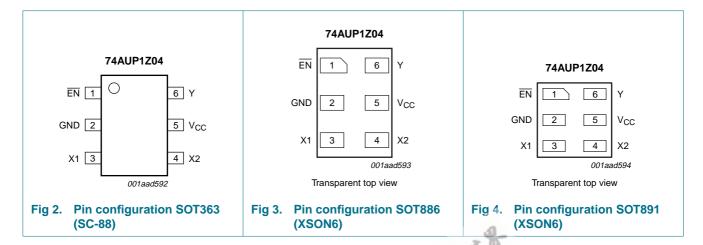
Fig 1. Logic symbol

74AUP1Z04 **NXP Semiconductors**

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Pinning information

6.1 Pinning



6.2 Pin description

Table 3. Pin description

	SC-88)	(XSON6)	(XSON6)
	6.2 Pin descrip	otion ** ** **	The state of the s
Table 3.	Pin description	36.73	M.L
Symbol	Pin	Description	
EN	1	enable input (active LOW)	
GND	2	ground (0 V)	
X1	3	data input	
X2	4	data output	
V_{CC}	5	supply voltage	
Υ	6	data output	

Functional description

Function table[1] Table 4.

Input X1		Output		
EN	X1	X2	Υ	
L	L	Н	L	
L	Н	L	Н	
Н	L	Н	L	
Н	Н	L	Н	

^[1] H = HIGH voltage level;

L = LOW voltage level.

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8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CC}	supply voltage		-0.5	+4.6	V
I _{IK}	input clamping current	$V_I < 0 V$	-	-50	mA
V_{I}	input voltage		<u>[1]</u> –0.5	+4.6	V
I _{OK}	output clamping current	$V_O > V_{CC}$ or $V_O < 0 V$	-	±50	mA
V_{O}	output voltage		<u>[1]</u> –0.5	$V_{CC} + 0.5$	V
I _O	output current	$V_O = 0 V \text{ to } V_{CC}$	-	±20	mA
I_{CC}	supply current		-	+50	mA
I_{GND}	ground current		-	-50	mA
T _{stg}	storage temperature		-65	+150	°C
P _{tot}	total power dissipation	$T_{amb} = -40 ^{\circ}\text{C} \text{ to } +125 ^{\circ}\text{C}$	[2] -	250	mW

^[1] The minimum input and output voltage ratings may be exceeded if the input and output current ratings are observed.

9. Recommended operating conditions

Table 6. Recommended operating conditions

Symbol	Parameter Conditions	Min	Max	Unit
V_{CC}	supply voltage	8.0	3.6	V
VI	input voltage	0	3.6	V
Vo	output voltage	0	V_{CC}	V
T _{amb}	ambient temperature	-40	+125	°C
$\Delta t/\Delta V$	input transition rise and fall rate $V_{CC} = 0.8 \text{ V}$ to 3.6 V	0	200	ns/V

10. Static characteristics

Table 7. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symb	ol Parameter	Conditions	Min	Тур	Max	Unit
T _{amb} =	: 25 °C					
V_{IH}	HIGH-level input voltage	X1 input				
		$V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	$0.75 \times V_{CC}$; -	-	V
		EN input				
		V _{CC} = 0.8 V	$0.70 \times V_{CO}$; -	-	V
		$V_{CC} = 0.9 \text{ V to } 1.95 \text{ V}$	$0.65 \times V_{CC}$; -	-	V
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.6	-	-	V
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	2.0	-	-	V

^[2] For SC-88 packages: above 87.5 °C the value of P_{tot} derates linearly with 4.0 mW/K. For XSON6 packages: above 45 °C the value of P_{tot} derates linearly with 2.4 mW/K.

Low-power X-tal driver with enable and internal resistor

Table 7. Static characteristics ...continued
At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{IL}	LOW-level input voltage	X1 input				
		$V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	-	-	$0.25 \times V_{CC}$	V
		EN input				
		$V_{CC} = 0.8 \text{ V}$	-	-	$0.30 \times V_{CC}$	V
		$V_{CC} = 0.9 \text{ V to } 1.95 \text{ V}$	-	-	$0.35 \times V_{CC}$	V
		V_{CC} = 2.3 V to 2.7 V	-	-	0.7	V
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	-	0.9	V
V _{OH}	HIGH-level output voltage	$V_I = V_{IH}$ or V_{IL}				
		$I_{O} = -20 \mu A$; $V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	V _{CC} - 0.1	-	-	V
		$I_{O} = -1.1 \text{ mA}; V_{CC} = 1.1 \text{ V}$	$0.75 \times V_{CC}$	-	-	V
		$I_{O} = -1.7 \text{ mA}; V_{CC} = 1.4 \text{ V}$	1.11	-	-	V
		$I_{O} = -1.9 \text{ mA}; V_{CC} = 1.65 \text{ V}$	1.32	-	-	V
		$I_{O} = -2.3 \text{ mA}; V_{CC} = 2.3 \text{ V}$	2.05	-	-	V
		$I_{O} = -3.1 \text{ mA}; V_{CC} = 2.3 \text{ V}$	1.9	-	-	V
		$I_{O} = -2.7 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.72	-	-	V
		$I_O = -3.1 \text{ mA}; V_{CC} = 2.3 \text{ V}$ $I_O = -2.7 \text{ mA}; V_{CC} = 3.0 \text{ V}$ $I_O = -4.0 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.6	-	-	٧
V _{OL}	LOW-level output voltage					
		$V_I = V_{IH} \text{ or } V_{IL}$ $I_O = 20 \mu\text{A; } V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$ $I_O = 1.1 \text{ mA; } V_{CC} = 1.1 \text{ V}$	-	-	0.1	V
		$I_{O} = 1.1 \text{ mA}; V_{CC} = 1.1 \text{ V}$	-	-	$0.3 \times V_{CC}$	V
		$I_{O} = 1.7 \text{ mA}; V_{CC} = 1.4 \text{ V}$	-	-	0.31	V
		$I_0 = 1.9 \text{ mA}; V_{CC} = 1.65 \text{ V}$	-	-	0.31	V
		$I_0 = 2.3 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	-	0.31	V
		I _O = 3.1 mA; V _{CC} = 2.3 V	-	-	0.44	V
		$I_O = 2.7 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.31	V
		$I_O = 4.0 \text{ mA}$; $V_{CC} = 3.0 \text{ V}$	-	-	0.44	V
l _l	input leakage current	X1 input				
		$V_I = \overline{EN} = V_{CC}$; $V_{CC} = 0 \text{ V to } 3.6 \text{ V}$	-	-	±0.1	μΑ
		EN input				
		$V_I = GND \text{ to } 3.6 \text{ V};$	-	-	±0.1	μΑ
		$V_{CC} = 0 V \text{ to } 3.6 V$				
I_{pu}	pull-up current	X1 input; $\overline{EN} = V_{CC}$				
		$V_I = GND$; $V_{CC} = 0.8 \text{ V}$ to 3.6 V	-	-	15	μΑ
I _{fbck}	feedback current	X1 input				
		$V_I = GND \text{ or } V_{CC}; \overline{EN} = GND;$ $V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	-	-	7.5	μΑ
l _{OFF}	power-off leakage current	V_I or $V_O = 0$ V to 3.6 V; $V_{CC} = 0$ V	<u>[1]</u> -	-	±0.2	μΑ
ΔI_{OFF}	additional power-off leakage current	$V_1 \text{ or } V_0 = 0 \text{ V to } 3.6 \text{ V};$ $V_{CC} = 0 \text{ V to } 0.2 \text{ V}$	<u>[1]</u> -	-	±0.2	μΑ
I _{CC}	supply current	$V_{I} = GND \text{ or } V_{CC}; I_{O} = 0 \text{ A};$ $\overline{EN} = GND; V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	-	-	10	μΑ

Low-power X-tal driver with enable and internal resistor

 Table 7.
 Static characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
ΔI_{CC}	additional supply current	EN input				
		$V_1 = V_{CC} - 0.6 \text{ V}; I_O = 0 \text{ A};$ $V_{CC} = 3.3 \text{ V}$	-	-	40	μΑ
Cı	input capacitance	X1 input				
		$V_{CC} = 0 \text{ V to } 3.6 \text{ V};$ $V_I = \text{GND or } V_{CC}$	-	1.5	-	pF
		EN input				
		$V_{CC} = 0 \text{ V to } 3.6 \text{ V};$ $V_I = \text{GND or } V_{CC}$	-	0.8	-	pF
Co	output capacitance	X2 output				
		$V_O = GND; V_{CC} = 0 V$	-	2.0	-	pF
		Y output				
		$V_O = GND; V_{CC} = 0 V$	-	1.8	-	pF
T _{amb} = -	40 °C to +85 °C		$0.75 \times V_{CC}$ $0.70 \times V_{CC}$			
V_{IH}	HIGH-level input voltage	X1 input	12			
		$V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	$0.75 \times V_{CC}$	-	-	V
		EN input	-w			
		V _{CC} = 0.8 V	$0.70 \times V_{CC}$	-	-	V
		$V_{CC} = 0.9 \text{ V to } 1.95 \text{ V}$	$0.65 \times V_{CC}$		-	V
		V_{CC} = 2.3 V to 2.7 V	1.6	-	-	V
		V_{CC} = 3.0 V to 3.6 V	2.0	-	-	V
V _{IL}	LOW-level input voltage	X1 input				
		$V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	-	-	$0.25 \times V_{CC}$	V
		EN input				
		$V_{CC} = 0.8 \text{ V}$	-	-	$0.30 \times V_{\text{CC}}$	V
		$V_{CC} = 0.9 \text{ V to } 1.95 \text{ V}$	-	-	$0.35 \times V_{\text{CC}}$	V
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	-	0.7	V
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	-	0.9	V
V _{OH}	HIGH-level output voltage	$V_I = V_{IH}$ or V_{IL}				
		$I_O = -20~\mu A;~V_{CC} = 0.8~V$ to 3.6 V	$V_{CC}-0.1$	-	-	V
		$I_O = -1.1 \text{ mA}; V_{CC} = 1.1 \text{ V}$	$0.7 \times V_{\text{CC}}$	-	-	V
		$I_O = -1.7 \text{ mA}; V_{CC} = 1.4 \text{ V}$	1.03	-	-	V
		$I_O = -1.9 \text{ mA}; V_{CC} = 1.65 \text{ V}$	1.30	-	-	V
		$I_O = -2.3 \text{ mA}; V_{CC} = 2.3 \text{ V}$	1.97	-	-	V
		$I_O = -3.1 \text{ mA}; V_{CC} = 2.3 \text{ V}$	1.85	-	-	V
		$I_{O} = -2.7 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.67	-	-	V
		$I_{O} = -4.0 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.55	-	-	V

Low-power X-tal driver with enable and internal resistor

Table 7. Static characteristics ...continued
At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{OL}	LOW-level output voltage	$V_I = V_{IH}$ or V_{IL}				
		I_{O} = 20 μ A; V_{CC} = 0.8 V to 3.6 V	-	-	0.1	V
		$I_{O} = 1.1 \text{ mA}; V_{CC} = 1.1 \text{ V}$	-	-	$0.3 \times V_{CC}$	V
		$I_{O} = 1.7 \text{ mA}; V_{CC} = 1.4 \text{ V}$	-	-	0.37	V
		$I_O = 1.9 \text{ mA}; V_{CC} = 1.65 \text{ V}$	-	-	0.35	V
		$I_{O} = 2.3 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	-	0.33	V
		$I_O = 3.1 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	-	0.45	V
		$I_{O} = 2.7 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.33	V
		$I_{O} = 4.0 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.45	V
I	input leakage current	X1 input				
		$V_I = \overline{EN} = V_{CC}$; $V_{CC} = 0 \text{ V to } 3.6 \text{ V}$	-	-	±0.5	μΑ
		EN input				
		$V_{I} = \text{GND to } 3.6 \text{ V};$ $V_{CC} = 0 \text{ V to } 3.6 \text{ V}$ $X1 \text{ input; } \overline{EN} = V_{CC}$ $V_{I} = \text{GND; } V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$ $X1 \text{ input}$ $V_{I} = \text{GND or } V_{CC}; \overline{EN} = \text{GND;}$ $V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	1 选品	-	±0.5	μΑ
pu	pull-up current	X1 input; $\overline{\text{EN}} = V_{\text{CC}}$	30			
		$V_{I} = GND; V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	-4-0	-	15	μΑ
fbck	feedback current	X1 input	14.0			
		$V_I = GND \text{ or } V_{CC}; \overline{EN} = GND;$ $V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	-	-	7.5	μΑ
loff	power-off leakage current	V_I or $V_O = 0$ V to 3.6 V; $V_{CC} = 0$ V	[1] -	-	±0.5	μΑ
ΔI_{OFF}	additional power-off leakage current	V_1 or $V_0 = 0$ V to 3.6 V; $V_{CC} = 0$ V to 0.2 V	[1] -	-	±0.6	μΑ
lcc	supply current	$V_I = GND \text{ or } V_{CC}; I_O = 0 \text{ A};$ $\overline{EN} = GND; V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	-	-	20	μΑ
Δl _{CC}	additional supply current	EN input				
		$V_I = V_{CC} - 0.6 \text{ V}; I_O = 0 \text{ A};$ $V_{CC} = 3.3 \text{ V}$	-	-	50	μΑ
Γ _{amb} =	40 °C to +125 °C					
V _{IH}	HIGH-level input voltage	X1 input				
		$V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	$0.75 \times V_{C0}$	c -	-	V
		EN input				
		V _{CC} = 0.8 V	$0.75 \times V_{CO}$	- ·	-	V
		V _{CC} = 0.9 V to 1.95 V	$0.70 \times V_{CO}$	- ·	-	V
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.6	-	-	V
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	2.0	-	-	V

Low-power X-tal driver with enable and internal resistor

Table 7. Static characteristics ...continued
At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{IL}	LOW-level input voltage	X1 input				
		$V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	-	-	$0.25 \times V_{CC}$	V
		EN input				
		$V_{CC} = 0.8 \text{ V}$	-	-	$0.25 \times V_{CC}$	V
		$V_{CC} = 0.9 \text{ V to } 1.95 \text{ V}$	-	-	$0.30 \times V_{CC}$	V
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	-	0.7	V
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	-	0.9	V
V _{OH}	HIGH-level output voltage	$V_I = V_{IH}$ or V_{IL}				V
		$I_O = -20 \mu A$; $V_{CC} = 0.8 \text{ V}$ to 3.6 V	V _{CC} – 0.11	-	-	V
		$I_O = -1.1 \text{ mA}; V_{CC} = 1.1 \text{ V}$	$0.6 \times V_{CC}$	-	-	V
		$I_O = -1.7 \text{ mA}; V_{CC} = 1.4 \text{ V}$	0.93	-	-	V
		$I_{O} = -1.9 \text{ mA}; V_{CC} = 1.65 \text{ V}$	1.17	-	-	V
		$I_{O} = -2.3 \text{ mA}; V_{CC} = 2.3 \text{ V}$	1.77	-	-	V
		$I_{O} = -3.1 \text{ mA}; V_{CC} = 2.3 \text{ V}$	1.67	-	-	V
		$I_{O} = -2.7 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.40	-	-	V
		$I_{O} = -3.1 \text{ mA}; V_{CC} = 2.3 \text{ V}$ $I_{O} = -2.7 \text{ mA}; V_{CC} = 3.0 \text{ V}$ $I_{O} = -4.0 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.30	-	-	V
V _{OL}	LOW-level output voltage	V _I = V _{IH} or V _{II}	18.0			
		$I_O = 20 \mu\text{A}$; $V_{CC} = 0.8 \text{V}$ to 3.6 V	-	-	0.11	V
		$I_{O} = 1.1 \text{ mA}; V_{CC} = 1.1 \text{ V}$	-	-	$0.33 \times V_{CC}$	V
		$I_{O} = 1.7 \text{ mA}; V_{CC} = 1.4 \text{ V}$	-	-	0.41	V
		$I_{O} = 1.9 \text{ mA}; V_{CC} = 1.65 \text{ V}$	-	-	0.39	V
		$I_O = 2.3 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	-	0.36	V
		$I_{\rm O}$ = 3.1 mA; $V_{\rm CC}$ = 2.3 V	-	-	0.50	V
		$I_O = 2.7 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.36	V
		$I_O = 4.0 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.50	V
I _I	input leakage current	X1 input				
		$V_I = \overline{EN} = V_{CC}$; $V_{CC} = 0 \text{ V to } 3.6 \text{ V}$	-	-	±0.5	μΑ
		EN input				
		$V_I = GND$ to 3.6 V;	-	-	±0.75	μΑ
		$V_{CC} = 0 \text{ V to } 3.6 \text{ V}$				
I_{pu}	pull-up current	X1 input; $\overline{EN} = V_{CC}$				
		$V_{I} = GND; V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	-	-	15	μΑ
I _{fbck}	feedback current	X1 input				
		$V_I = GND \text{ or } V_{CC}; \overline{EN} = GND;$ $V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	-	-	7.5	μΑ
l _{OFF}	power-off leakage current	V_I or $V_O = 0$ V to 3.6 V; $V_{CC} = 0$ V	[1] _	-	±0.75	μΑ
ΔI_{OFF}	additional power-off leakage current	V_1 or $V_0 = 0$ V to 3.6 V; $V_{CC} = 0$ V to 0.2 V	[1] -	-	±0.75	μΑ

Low-power X-tal driver with enable and internal resistor

 Table 7.
 Static characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I _{CC}	supply current	V_I = GND or V_{CC} ; I_O = 0 A; \overline{EN} = GND; V_{CC} = 0.8 V to 3.6 V	-	-	25	μΑ
ΔI_{CC}	Δl _{CC} additional supply current	EN input				
		$V_I = V_{CC} - 0.6 \text{ V}; I_O = 0 \text{ A};$ $V_{CC} = 3.3 \text{ V}$	-	-	75	μΑ

^[1] Only for output Y and input \overline{EN} .

11. Dynamic characteristics

Table 8. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V); for test circuit see Figure 7.

Symbol	Parameter	Conditions		25 °C		-40 °C to +125 °C			Unit	
			Min	Typ[1]	Max	Min	Max (85 °C)	Max (125 °C)		
$C_L = 5 pl$	F				_ <	100				
t _{pd} propagation dela		X1 to X2; see Figure 5	2]		4000	4	11.			
		$V_{CC} = 0.8 \text{ V}$	4	1.2	12.8	400	-	-	-	ns
		V _{CC} = 1.1 V to 1.3 V		1.2	3.0	3.9	1.2	3.9	3.9	ns
		V _{CC} = 1.4 V to 1.6 V		1.0	2.2	2.6	1.0	2.7	2.7	ns
		V _{CC} = 1.65 V to 1.95 V	Ţ	0.8	1.9	2.3	8.0	2.4	2.5	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0.7	1.6	1.9	0.7	2.0	2.0	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		0.7	1.4	1.6	0.7	1.7	1.7	ns
		X1 to Y; see Figure 6	2]							
		$V_{CC} = 0.8 \text{ V}$		-	39.2	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$		2.5	8.0	10.7	2.3	10.8	10.9	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$		2.2	5.5	6.6	2.0	7.0	7.0	ns
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$		1.8	4.4	5.5	1.7	5.9	6.0	ns
		V_{CC} = 2.3 V to 2.7 V		1.5	3.5	4.1	1.4	4.4	4.5	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		1.5	3.1	3.5	1.4	3.8	3.8	ns

Low-power X-tal driver with enable and internal resistor

Table 8. Dynamic characteristics ...continued Voltages are referenced to GND (ground = 0 V); for test circuit see Figure 7.

Symbol	Parameter	Conditions		25 °C		-40	°C to +1	25 °C	Unit
			Min	Typ[1]	Max	Min	Max (85 °C)	Max (125 °C)	
C _L = 10	pF					•			
t _{pd} propagation delay		X1 to X2; see Figure 5							
		$V_{CC} = 0.8 \text{ V}$	-	20.9	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	1.4	4.1	5.4	1.3	5.6	5.6	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	1.3	2.9	3.6	1.2	3.8	3.8	ns
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	1.2	2.5	3.0	1.1	3.2	3.2	ns
		V_{CC} = 2.3 V to 2.7 V	0.9	2.0	2.4	8.0	2.5	2.5	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	0.9	1.8	2.1	8.0	2.3	2.3	ns
		X1 to Y; see Figure 6							
		$V_{CC} = 0.8 \text{ V}$	-	46.6	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	2.7	9.2	12.4	2.5	12.7	12.7	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	2.5	6.3	7.8	2.2	8.2	8.2	ns
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	2.3	5.0	6.2	2.2	6.7	6.7	ns
		V_{CC} = 2.3 V to 2.7 V	201	4.0	4.7	1.7	5.0	5.1	ns
		V _{CC} = 3.0 V to 3.6 V	1.9	3.6	4.2	1.8	4.5	4.5	ns
C _L = 15	pF			6					
t_{pd}	propagation delay	X1 to X2; see Figure 5							
		$V_{CC} = 0.8 \text{ V}$	-	28.9	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	1.7	5.2	7.1	1.6	7.2	7.3	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	1.6	3.6	4.4	1.6	4.7	4.8	ns
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	1.3	3.0	3.7	1.3	3.9	4.0	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.0	2.4	2.9	1.0	3.1	3.1	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	1.1	2.2	2.5	1.0	2.7	2.7	ns
		X1 to Y; see Figure 6 [2]							
		$V_{CC} = 0.8 \text{ V}$	-	53.9	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	3.1	10.4	14.2	2.8	14.6	14.7	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	2.9	7.0	8.5	2.7	9.2	9.3	ns
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	2.5	5.6	6.9	2.3	7.4	7.5	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	2.1	4.5	5.4	2.0	5.7	5.7	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	2.3	4.1	4.7	2.1	5.1	5.1	ns

Low-power X-tal driver with enable and internal resistor

 Table 8.
 Dynamic characteristics ...continued

Voltages are referenced to GND (ground = 0 V); for test circuit see Figure 7.

Symbol	Parameter	Conditions		25 °C		-40	°C to +1	25 °C	Unit
			Min	Typ[1]	Max	Min	Max (85 °C)	Max (125 °C)	
$C_L = 30 \mu$	ρF								
t _{pd}	propagation delay	X1 to X2; see Figure 5							
		$V_{CC} = 0.8 \text{ V}$	-	52.8	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$		8.5	11.8	2.3	12.2	12.4	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	2.2	5.6	6.8	2.0	7.5	7.6	ns
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$		4.5	5.6	1.9	6.2	6.2	ns
		V_{CC} = 2.3 V to 2.7 V	1.5	3.7	4.2	1.4	4.6	4.6	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	1.7	3.3	3.7	1.6	4.0	4.2	ns
		X1 to Y; see Figure 6							
		$V_{CC} = 0.8 \text{ V}$	-	77.6	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	3.7	13.8	19.2	3.3	19.8	20.1	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	3.4	9.2	11.2	3.1	12.2	12.3	ns
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	3.4	7.4	8.8	3.1	9.7	9.7	ns
		V_{CC} = 2.3 V to 2.7 V		5.9	6.7	2.4	7.4	7.4	ns
		V _{CC} = 3.0 V to 3.6 V	3.2	5.4	6.2	2.9	6.7	6.9	ns
$C_L = 5 pl$	F, 10 pF, 15 pF and	30 pF		C					
C_{PD}	power dissipation	$\overline{EN} = GND; f_i = 1 MHz$ [3][4][5]							
	capacitance	$V_{CC} = 0.8 \text{ V}$	-	5.3	-	-	-	-	pF
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	-	5.4	-	-	-	-	pF
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	-	5.6	-	-	-	-	pF
		$V_{CC} = 1.65 \text{ V}$ to 1.95 V	-	6.3	-	-	-	-	pF
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	9.6	-	-	-	-	pF
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	12.6	-	-	-	-	pF

- [1] All typical values are measured at nominal V_{CC} .
- [2] t_{pd} is the same as t_{PLH} and t_{PHL} .
- [3] All specified values are the average typical values over all stated loads.
- [4] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

 $P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \Sigma (C_L \times V_{CC}^2 \times f_o)$ where:

f_i = input frequency in MHz;

f_o = output frequency in MHz;

C_L = output load capacitance in pF;

V_{CC} = supply voltage in V;

N = number of inputs switching;

 $\Sigma(C_L \times V_{CC}^2 \times f_o)$ = sum of the outputs.

[5] Feedback current is included in the C_{PD}.

Low-power X-tal driver with enable and internal resistor

12. Waveforms

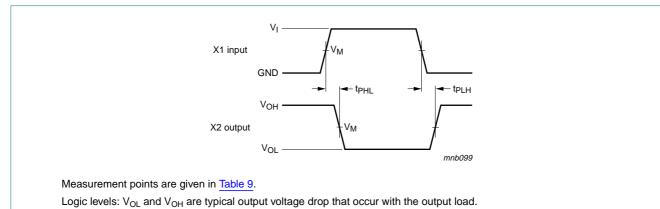


Fig 5. The input (X1) to output (X2) propagation delays

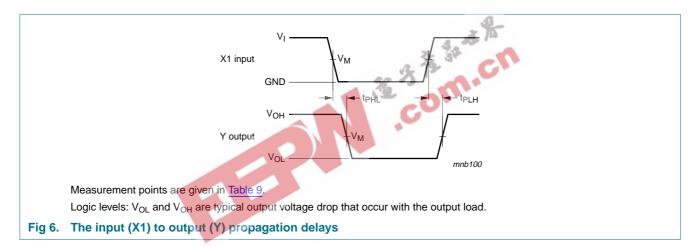
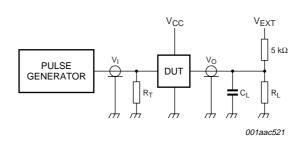


Table 9. Measurement points

Supply voltage	Output	Input					
V _{CC}	V _M	V _M	VI	$t_r = t_f$			
0.8 V to 3.6 V	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$	V _{CC}	≤ 3.0 ns			

Low-power X-tal driver with enable and internal resistor



Test data is given in Table 10.

Definitions for test circuit:

R_L = Load resistance.

C_L = Load capacitance including jig and probe capacitance.

 R_T = Termination resistance should be equal to the output impedance Z_0 of the pulse generator.

 V_{EXT} = External voltage for measuring switching times.

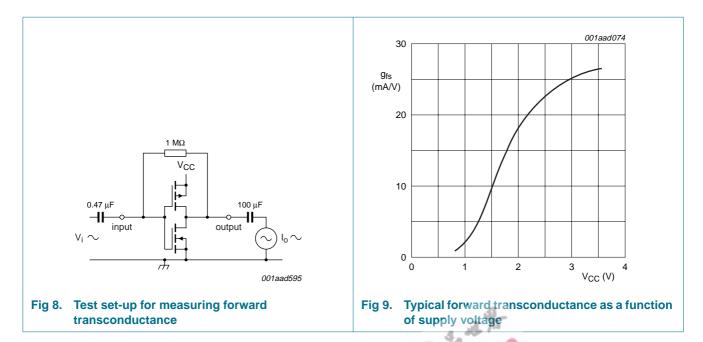
Fig 7. Load circuitry for switching times

Table 10. Test data

Supply voltage	Load	V _{EXT}			
V _{CC}	C _L	R _L [1]	t _{PLH} , t _{PHL}	t _{PZH} , t _{PHZ}	t _{PZL} , t _{PLZ}
0.8 V to 3.6 V	5 pF, 10 pF, 15 pF and 30 pF	5 k Ω or 1 M Ω	open	GND	$2 \times V_{CC}$

[1] For measuring enable and disable times R_L = 5 k Ω , for measuring propagation delays, setup and hold times and pulse width R_L = 1 M Ω .

Low-power X-tal driver with enable and internal resistor



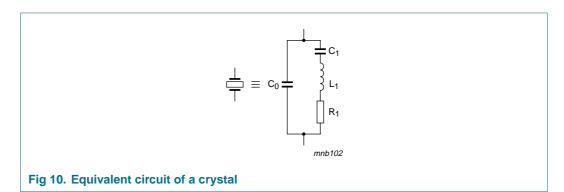
13. Application information

Crystal controlled oscillator circuits are widely used in clock pulse generators because of their excellent frequency stability and wide operating frequency range. The use of the 74AUP1Z04 provides the additional advantages of low power dissipation, stable operation over a wide range of frequency and temperature and a very small footprint. This application information describes crystal characteristics, design and testing of crystal oscillator circuits based on the 74AUP1Z04.

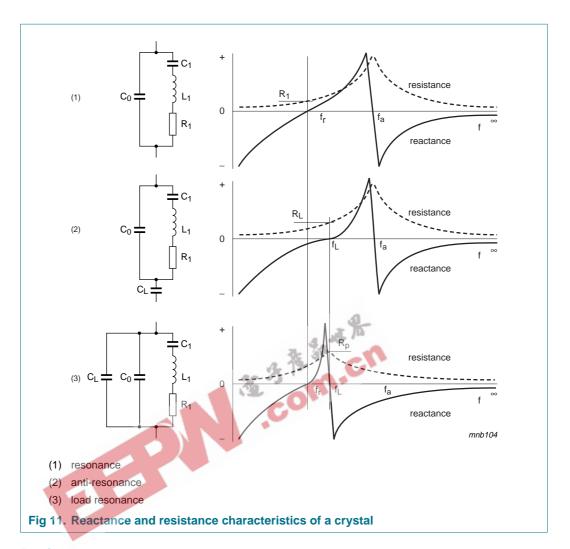
13.1 Crystal characteristics

Figure 10 is the equivalent circuit of a quartz crystal.

The reactive and resistive component of the impedance of the crystal alone and the crystal with a series and a parallel capacitance is shown in Figure 11



Low-power X-tal driver with enable and internal resistor



13.1.1 **Design**

<u>Figure 12</u> shows the recommended way to connect a crystal to the 74AUP1Z04. This circuit is basically a Pierce oscillator circuit in which the crystal is operating at its fundamental frequency and is tuned by the parallel load capacitance of C_1 and C_2 . C_1 and C_2 are in series with the crystal. They should be approximately equal. R_1 is the drive-limiting resistor and is set to approximately the same value as the reactance of C_1 at the crystal frequency ($R_1 = X_{C1}$). This will result in an input to the crystal of 50 % of the rail-to-rail output of X2. This keeps the drive level into the crystal within drive specifications (the designer should verify this). Overdriving the crystal can cause damage.

The internal 1 M Ω resistor provides negative feedback and sets a bias point of the inverter near mid-supply, operating the 74AUP1GU04 portion in the high gain linear region.

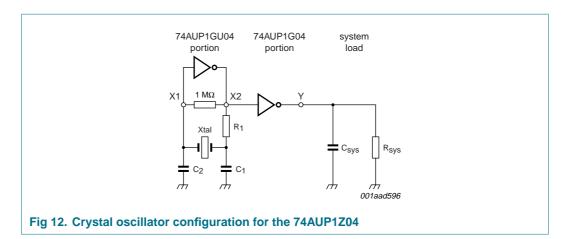
To calculate the values of C_1 and C_2 , the designer can use the formula:

$$C_L = \frac{C_1 \times C_2}{C_1 + C_2} + C_s$$

 C_L is the load capacitance as specified by the crystal manufacturer, C_s is the stray capacitance of the circuit (for the 74AUP1Z04 this is equal to an input capacitance of 1.5 pF).

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Low-power X-tal driver with enable and internal resistor



13.1.2 Testing

After the calculations are performed for a particular crystal, the oscillator circuit should be tested. The following simple checks will verify the prototype design of a crystal controlled oscillator circuit. Perform them after laying out the board:

- Test the oscillator over worst-case conditions (lowest supply voltage, worst-case crystal and highest operating temperature). Adding series and parallel resistors can simulate a worst-case crystal.
- Insure that the circuit does not oscillate without the crystal.
- Check the frequency stability over a supply range greater than that which is likely to occur during normal operation.
- Check that the start-up time is within system requirements.

As the 74AUP1Z04 isolates the system loading, once the design is optimized, the single layout may work in multiple applications for any given crystal.

Low-power X-tal driver with enable and internal resistor

14. Package outline

Plastic surface-mounted package; 6 leads

SOT363

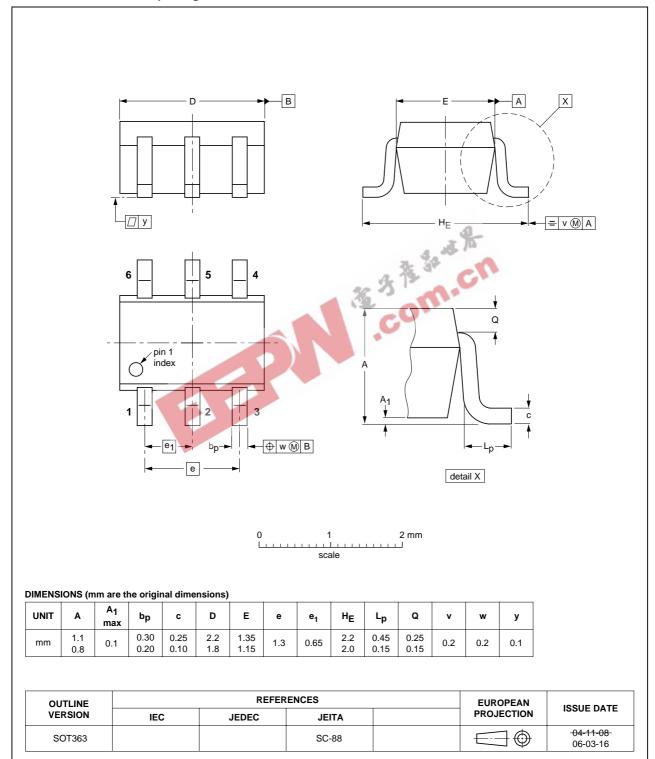


Fig 13. Package outline SOT363 (SC-88)

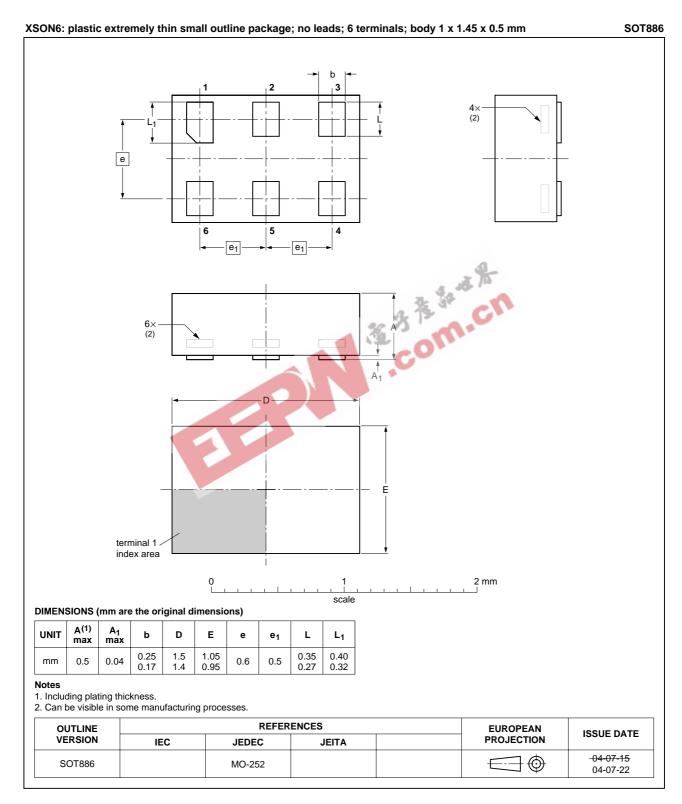


Fig 14. Package outline SOT886 (XSON6)

Low-power X-tal driver with enable and internal resistor

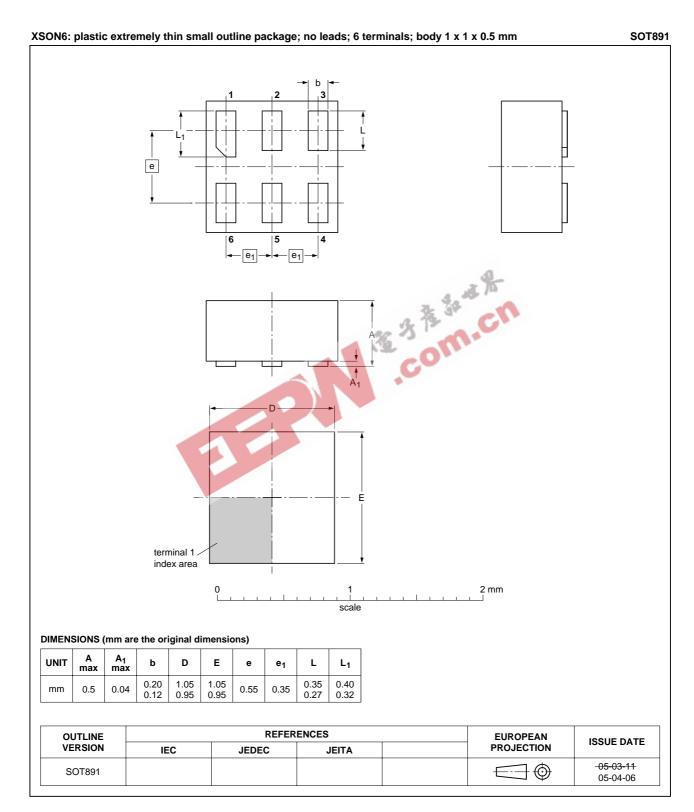


Fig 15. Package outline SOT891 (XSON6)

74AUP1Z04 **NXP Semiconductors**

Low-power X-tal driver with enable and internal resistor

15. Abbreviations

Table 11. Abbreviations

Acronym	Description
CDM	Charged Device Model
CMOS	Complementary Metal Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MM	Machine Model
TTL	Transistor-Transistor Logic

16. Revision history

Table 12. Revision history

Document ID Rele	ease date Data sheet status	Change notice	Supersedes
74AUP1Z04_1 200	Product data sheet	4.45	-
		.com.cl	

Low-power X-tal driver with enable and internal resistor

17. Legal information

17.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions"
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